

TRANSISTOR MOS-FET IGBT DIODE

△V_{BE}/△V_{Ds}/△V_{Ge}/△V_{CE}/△V_F TESTER 過渡熱抵抗測定器

DVFN240BS **200V
40A**



●DVFN240BS is the high accuracy thermal resistance tester which can measure VF1 and ΔVF with 0.1mV accuracy. Power time is 99.9 sec maximum at 100W.

●DVFN240BSはVF1とΔVFを0.1mV精度で測定可能な高精度熱抵抗テスターです。また、パワータイムは100Wで最大99.9secを持っています。

MODEL	DVFN240BS
MEASUREMENT RANGE	
PRE-TEST	B-E OPEN/SHORT
V _{BE1} /V _{Ds1} /V _{CE1} /V _{F1}	0000.0mV~3200.0mV
ΔV _{BE} /ΔV _{Ds} /ΔV _{CE} /ΔV _F	000.0mV~999.9mV
SETTING RANGE	
MEASURABLE DEVICES	NPN/PNP, N/P-MOS FET, N/P-DIODE, N/P-IGBT(GE), N/P-IGBT(CE)
V _{CB/VDS}	1V~199V
I _{E/ID}	0.01A~39.99A(10mA STEP)
I _M	1mA~99mA
POWER FORCING TIME(PT)	100μs~99.9s
DELAY TIME(DT)	10μs~999μs
GATE LIMIT(GL)	1.0V~19.9V
LOWER GATE(LG)/UPPER GATE(UG)	000.0mV~999.9mV
BINNING	
OPEN/SHORT CHECK	VF1 > 3V → OPEN VF1 < 0.2V → SHORT
BIN INDICATION	PASS, LOW, HIGH, AVAL, REJECT
DIMENSIONS & WEIGHT	
MAIN UNIT	430(W) × 700(D) × 245(H) ... 44kg
POWER UNIT	430(W) × 700(D) × 245(H) ... 47kg

Forcing Power Range Diagram

